

Ultrafast time diagnostics

by

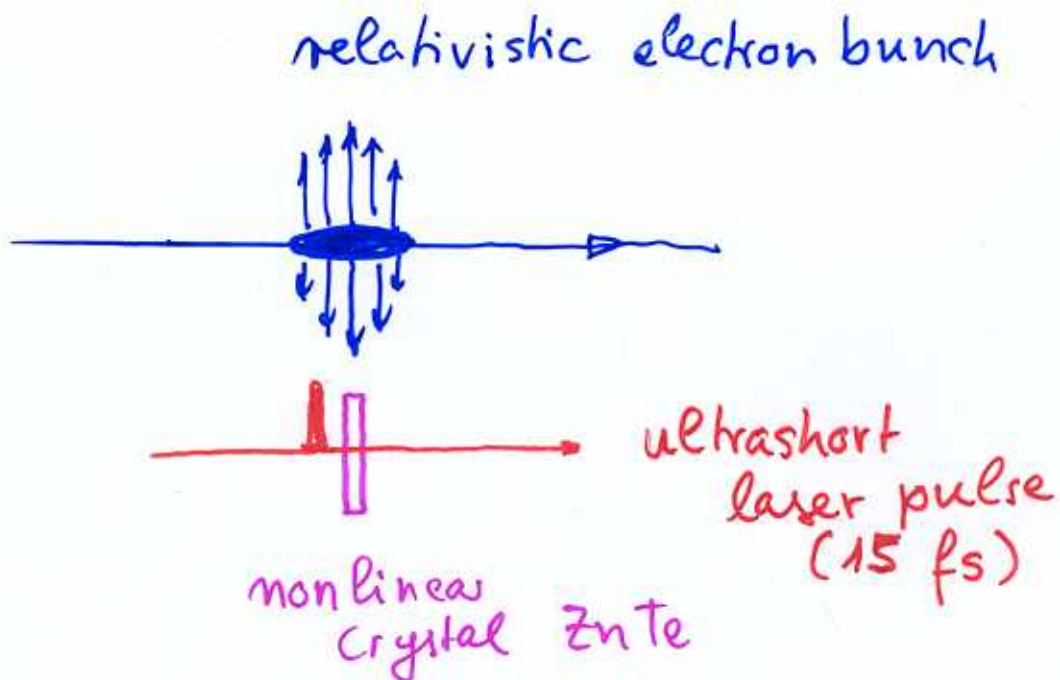
Electro-Optic Sampling

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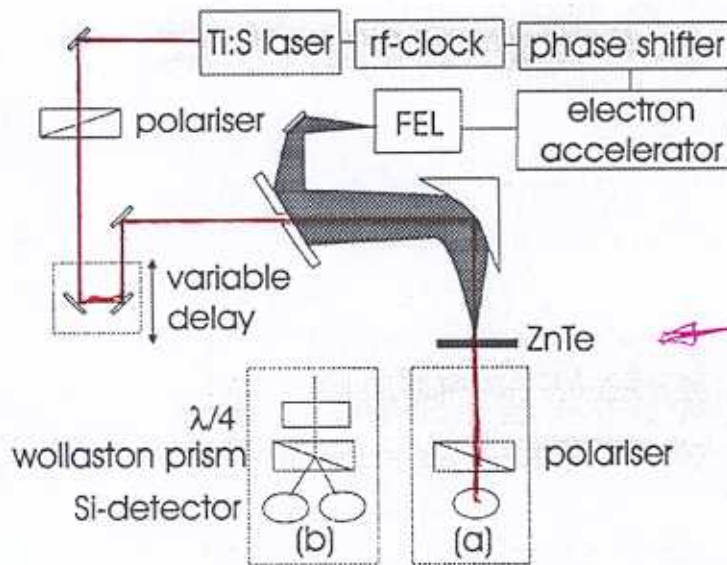
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\vec{E} field induces birefringence in ZnTe
(Doppelbrechung)

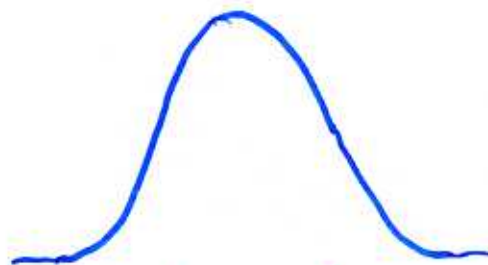
optical anisotropy is sampled with
ultrashort linearly polarized laser pulse

Electro-optic sampling (EOS) at the infrared FEL FELIX in Holland G. Knippels et al



electro-optic
crystal
Zn Te

FIG. 2. The EO cross-correlation setup with two different detectors (a) and (b). In (a) the measured photodiode intensity is proportional to the FEL intensity. In (b) the measured photodiode intensity is proportional to the instantaneous electric field strength of the FEL pulse.



THz signal from FEL
several ps wide



< 20 fs titanium-sapphire
laser pulse

electric field induces birefringence
(Doppelbrechung)
sampled with ultrashort

double-balanced mixer (DBM), the electron gun and the accelerator generate the electron beam that the silicon diode (Si-PIN) detects the train and filters out the 1-GHz with the 1-GHz clock in the finding the phase difference. After a 1-GHz low-pass filter (LPF) and a 1-GHz bandpass filter (BPF), the error signal is sent to a phase-locked loop (PLL) driver for adjustment of the Ti:sapphire laser. A phase-locked loop (PLL) driver is used to control temporal synchronization between the two lasers in a correlation experiment. The sum of the two pulses is measured through a calcite polarizer to vary the optical delay line to vary the optical delay between the two pulses, and the individual pulses correspond to a 50-shot-averaged successive macropulses. The Ti:sapphire laser pulses were measured with an autocorrelator that was found to be accurate and was found to be accurate. The single-pulse width was measured to be 435 fs FWHM (left-hand-side inset in Fig. 2). The jitter was thus estimated to be 400 fs FWHM, assuming a jitter of 900 fs FWHM, assuming a jitter of 900 fs FWHM. The degree of synchronization was present over many measurements. The system was competitive with other available systems that allow synchronization to an external clock. For comparison, Coherent systems typically have a jitter of more than 3 ps rms (~6 ps FWHM) or shorter for table-top systems. The FEL was located 40 m from the laser and the excellent synchronization demonstrates the intrinsic synchronization of the Ti:sapphire laser to the FEL to its 1-GHz clock. The synchronization between the laser and the FEL led to a synchronization of ~1 ps.

the synchronization of the FEL at an IR wave-

pulse (pulse duration, 0.5–1 ps; energy, ~1 μ J per micropulse) to heat the electron gas by promoting electrons from lower to higher states in the conduction band, by means of an intraband absorption process. We then used the delayed Ti:sapphire pulse to measure a change in transmission of the interband transition at wavelengths near the bandgap of GaAs.

In Fig. 3 the results at room temperature are given for different FEL wavelengths. The results clearly show a FEL-induced enhanced absorption that decays on a time scale of several picoseconds. The fast rising edge of the signal is another indication of the good synchronization between the two lasers. The transmission is decreased because after FEL excitation more states near the bottom of the conduction band to which electrons can be excited from the valence band at the Ti:sapphire wavelength become available. The decay time of the signal agrees with the typical cooling times of the hot electron gas, caused by longitudinal-optical-phonon emission.¹⁰ The longer decay time in

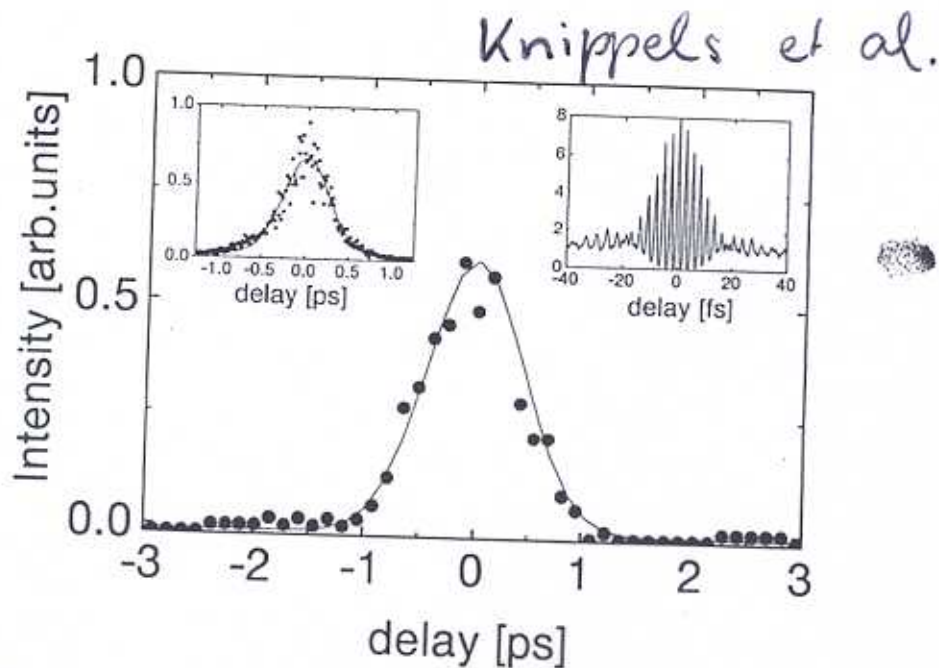
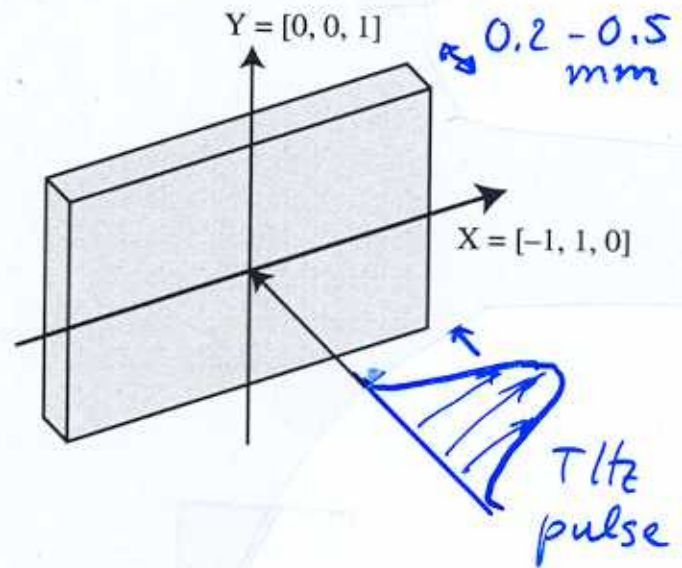
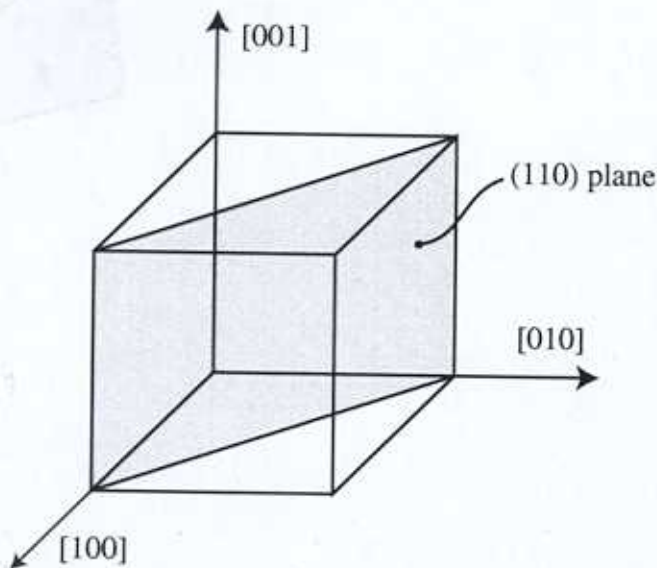


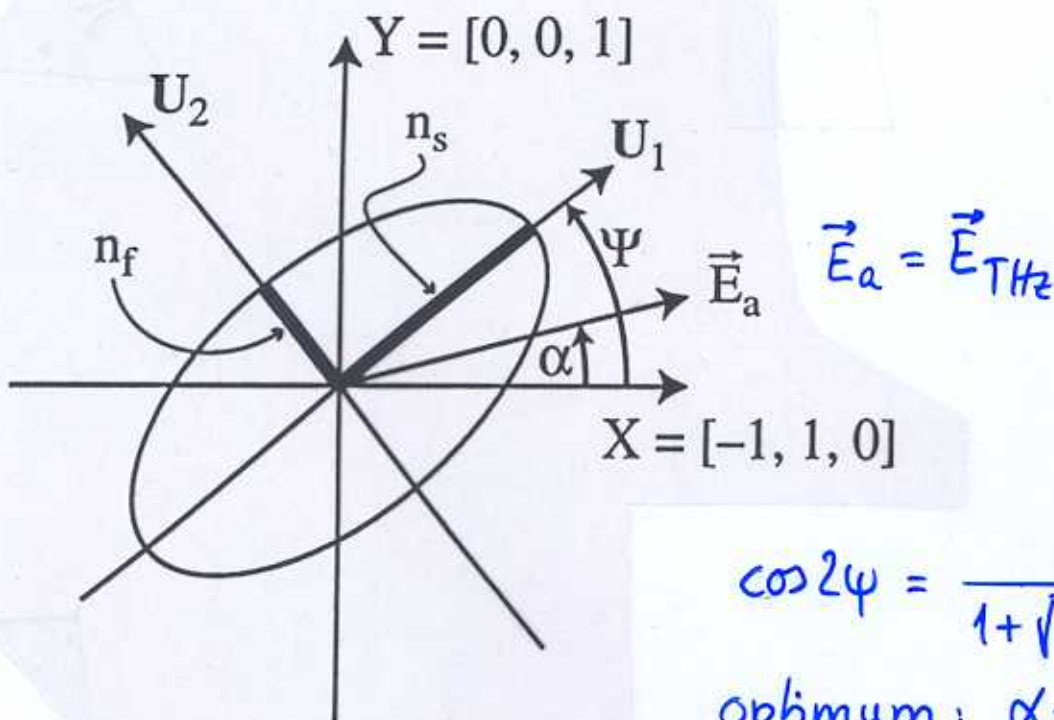
Fig. 2. Measured optical cross correlation between the FEL running at 9 μ m and the Ti:sapphire laser at 800 nm in a 100- μ m-thick AgGaS₂ crystal. The inset on the left-hand side shows the background-free autocorrelation measurement of the 435-fs FEL pulse with a homebuilt autocorrelator based on CdTe,⁶ and the inset on the right-hand side shows the 10-fs fringe-resolved autocorrelation function of the Ti:sapphire pulse. The derived jitter is 400 fs rms (~900 fs FWHM). The scan took approximately 2 min to record.

Electro-optic effect in zinc-telluride

ZnTe is optically isotropic without \vec{E} -field



with electric field: refractive index ellipsoid

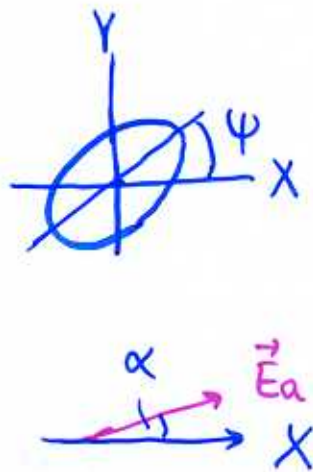
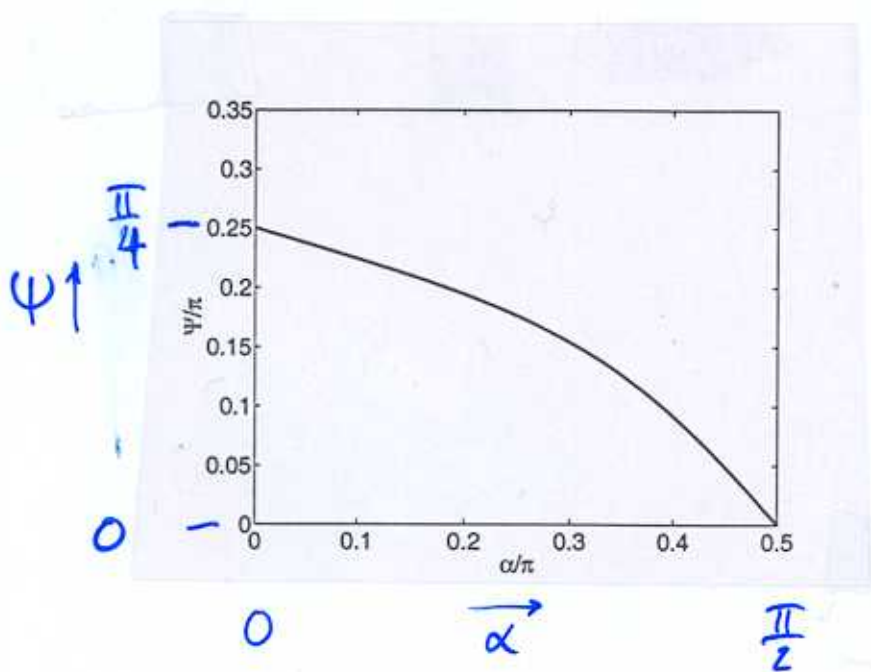


$$\cos 2\psi = \frac{\sin \alpha}{1 + \sqrt{1 + 3 \cos^2 \alpha}}$$

optimum: $\alpha = 0$

$$\Rightarrow \psi = \frac{\pi}{4} \hat{=} 45^\circ$$

orientation of ellipse in (110) plane



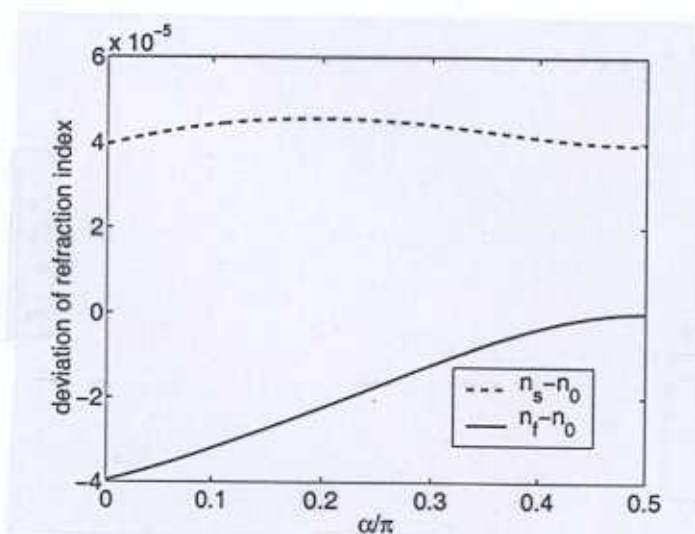
main refractive indices:

$$n_{\text{slow}} = n_1 = n_0 + \frac{1}{4} n_0^3 r_{41} \cdot E_a \cdot (\sin \alpha + \sqrt{1 + 3 \cos^2 \alpha})$$

$$n_{\text{fast}} = n_2 = n_0 + \frac{1}{4} n_0^3 r_{41} \cdot E_a \cdot (\sin \alpha - \sqrt{1 + 3 \cos^2 \alpha})$$

electro-optic coefficient of ZnTe:

$$r_{41} = 4 \cdot 10^{-12} \frac{\text{m}}{\text{V}}$$



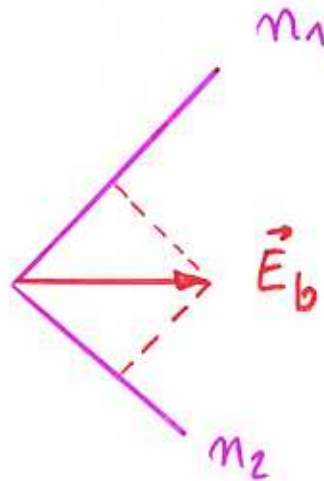
$\leftarrow n_1 = n_{\text{slow}}$

$\leftarrow n_2 = n_{\text{fast}}$

$n_1 - n_2 = \text{max}$
for $\alpha = 0$

Consider horizontally polarized Ti:Sa laser pulse

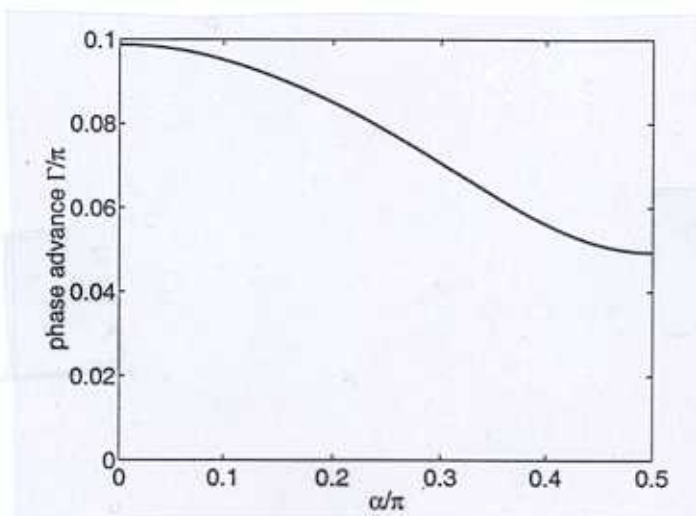
$$\vec{E}_b \equiv \vec{E}_{\text{TiSa}}$$



projections of \vec{E}_b on the n_1 axis and the n_2 axis receive different phase shifts

$$\Gamma = \frac{\omega d}{c} (n_1 - n_2) = \frac{\omega d}{2c} n_0^3 r_{41} E_a \sqrt{1 + 3\cos^2 \alpha}$$

$$\frac{\Gamma(\alpha)}{\pi}$$



$$0 \rightarrow \alpha \rightarrow \pi/2$$

$$\Gamma = 0.1 \pi$$

for $E_{\text{THz}} \approx 10^6 \text{ V/m}$
 $d = 0.5 \text{ mm}$
 (at $\alpha = 0$)

The Ti:Sa beam is elliptically polarized behind the ZnTe crystal

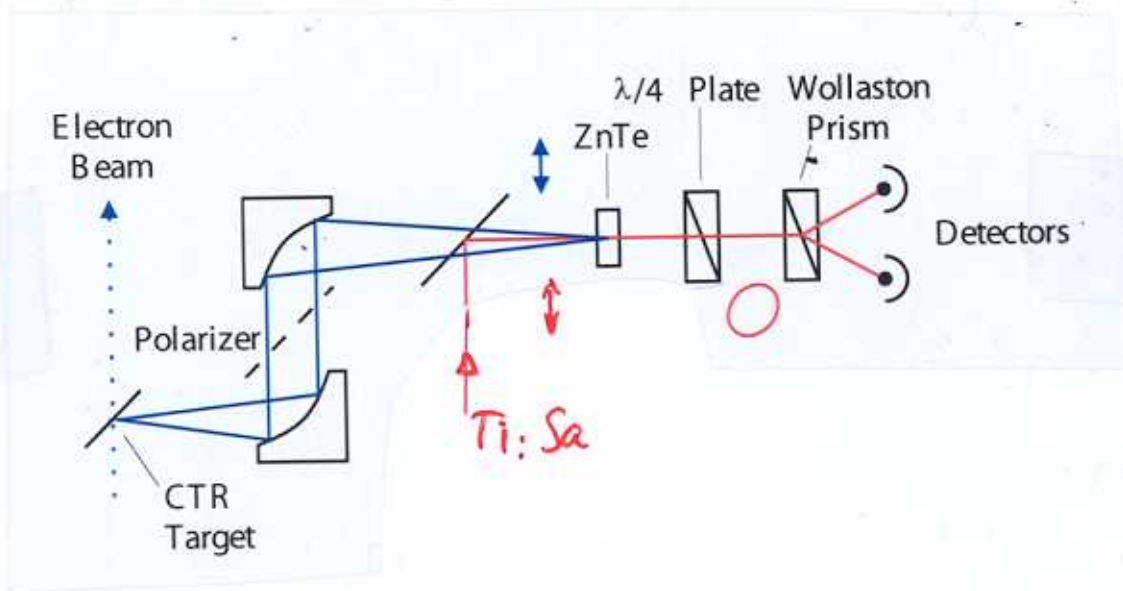
How to detect elliptic polarization?

a) Crossed polarizer

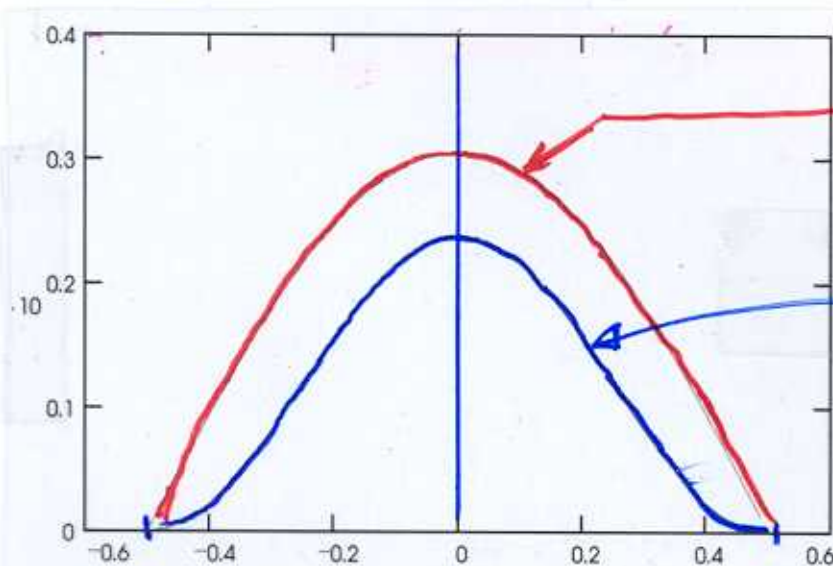
Detector signal

$$S(\alpha) = E_{TiSa}^2 \cdot \sin^2(2\psi(\alpha)) \cdot \sin^2\left(\frac{\Gamma(\alpha)}{2}\right)$$

b) $\frac{\lambda}{4}$ plate, Wollaston prism, balanced diode detector



difference signal $\sim E_{TiSa}^2 \cdot \sin(\Gamma(\alpha))$



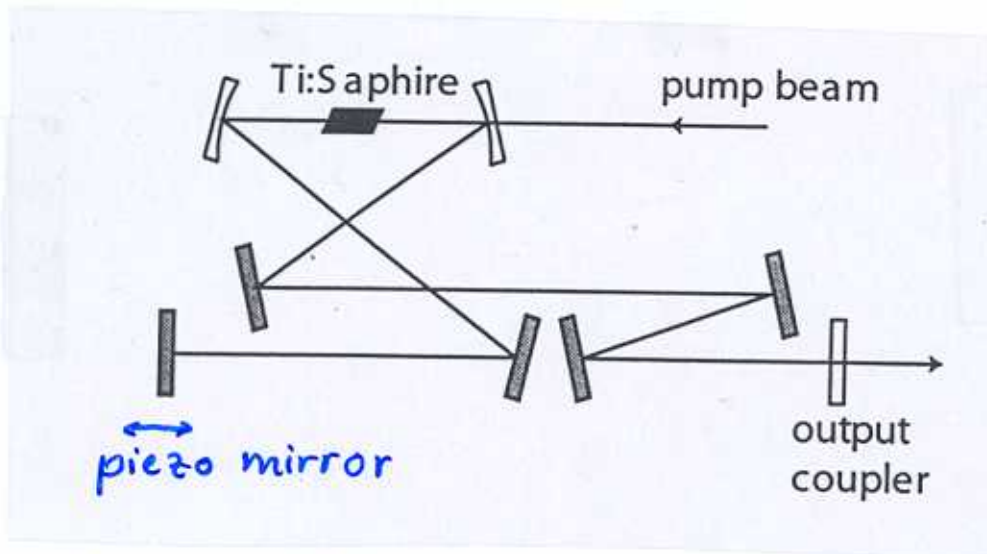
difference signal

crossed polarizer $\times 10$

$$(E_{THz} = 9 \cdot 10 \frac{SV}{m})$$

Titanium-Sapphire (Ti:Sa) laser

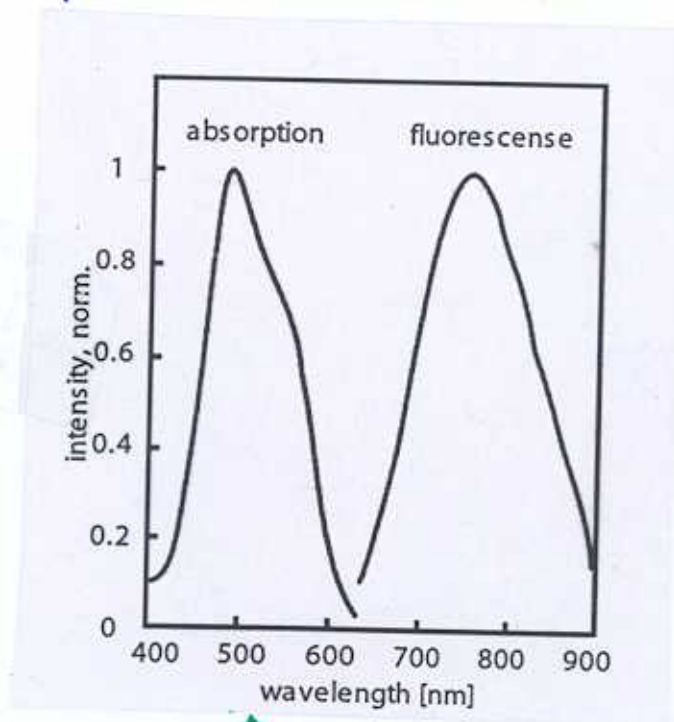
Femto source Compact by Femtolasers, Vienna



bandwidth 770 - 840 nm

pulse width 15 fs (FWHM)

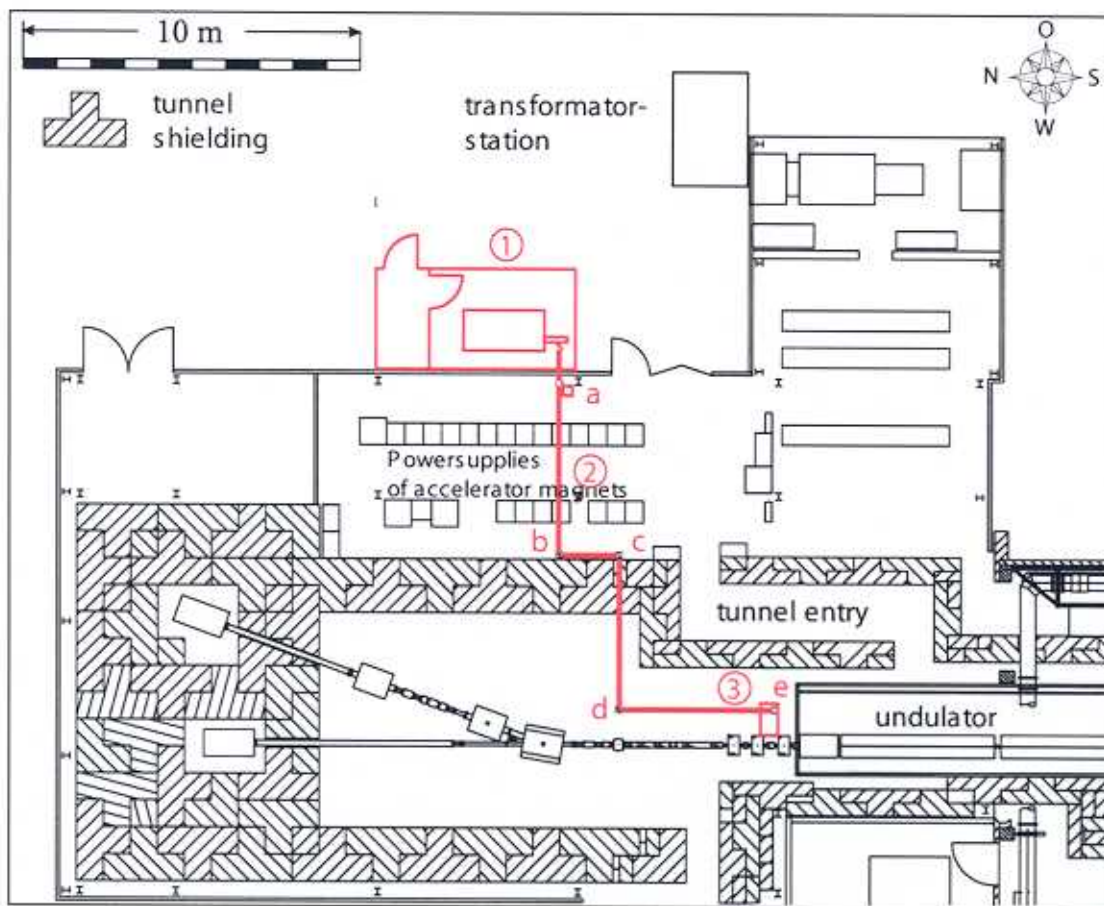
repetition rate 81 MHz

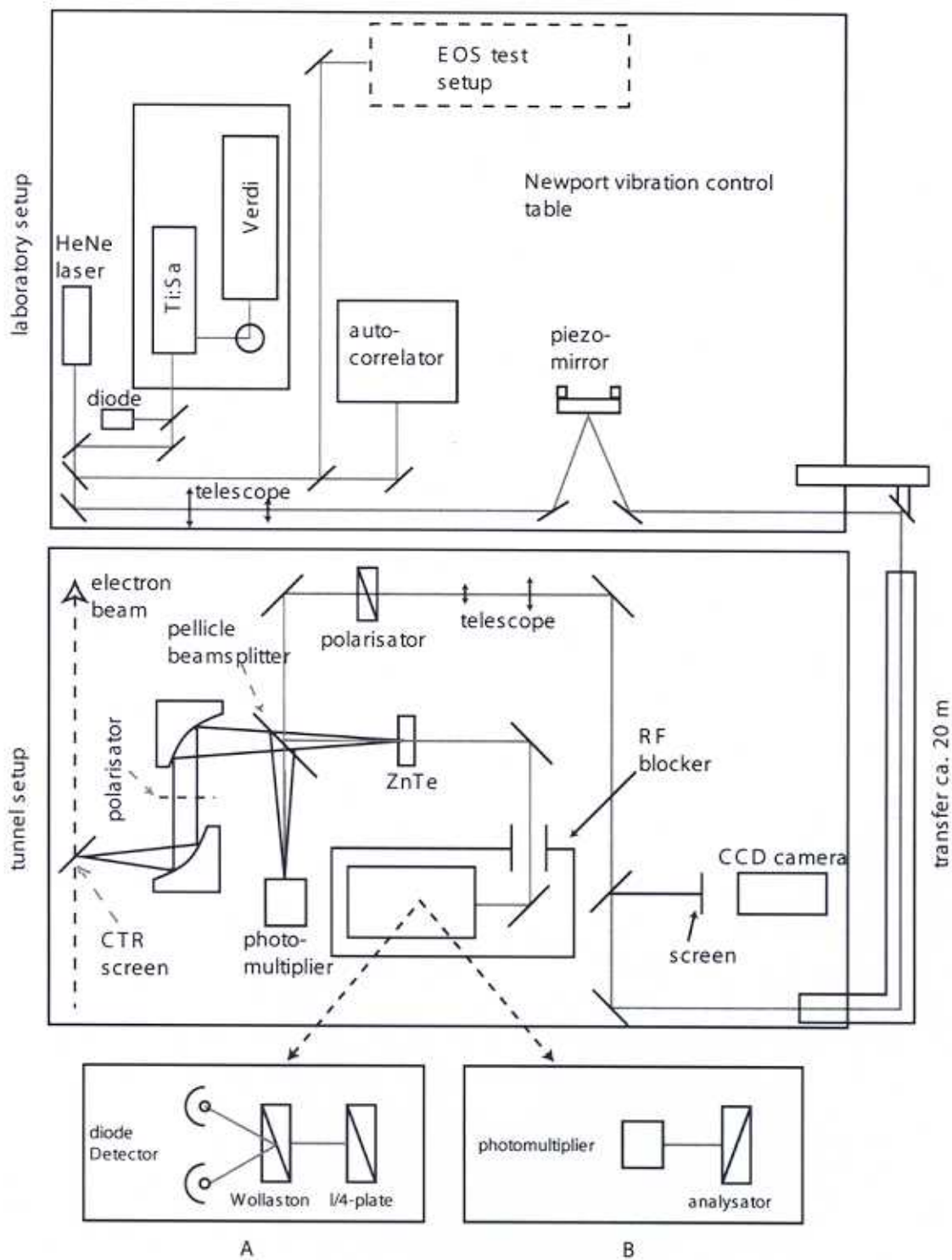


↑
pump laser 532 nm

5W CW

Verdi by Coherent





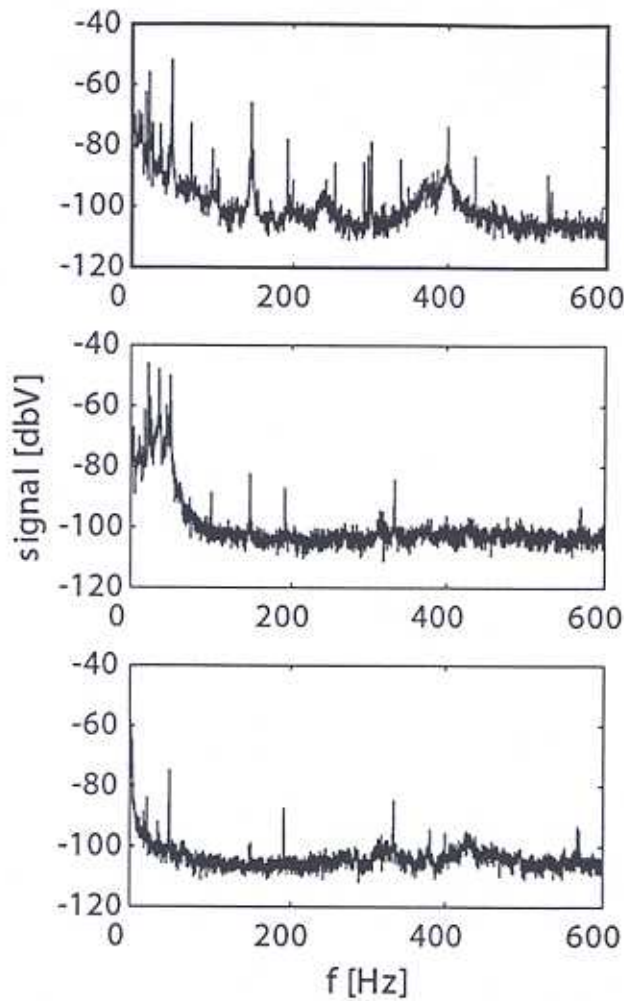


Figure 13: Vibrational noise in laser beam transport. Top and middle: two positions on a vertical I-beam in Hall 3. Bottom: vibrational noise at a mirror mounted on a vibration-damped vertical pillar.

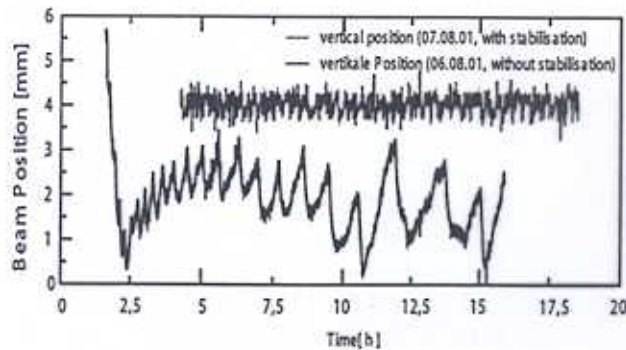
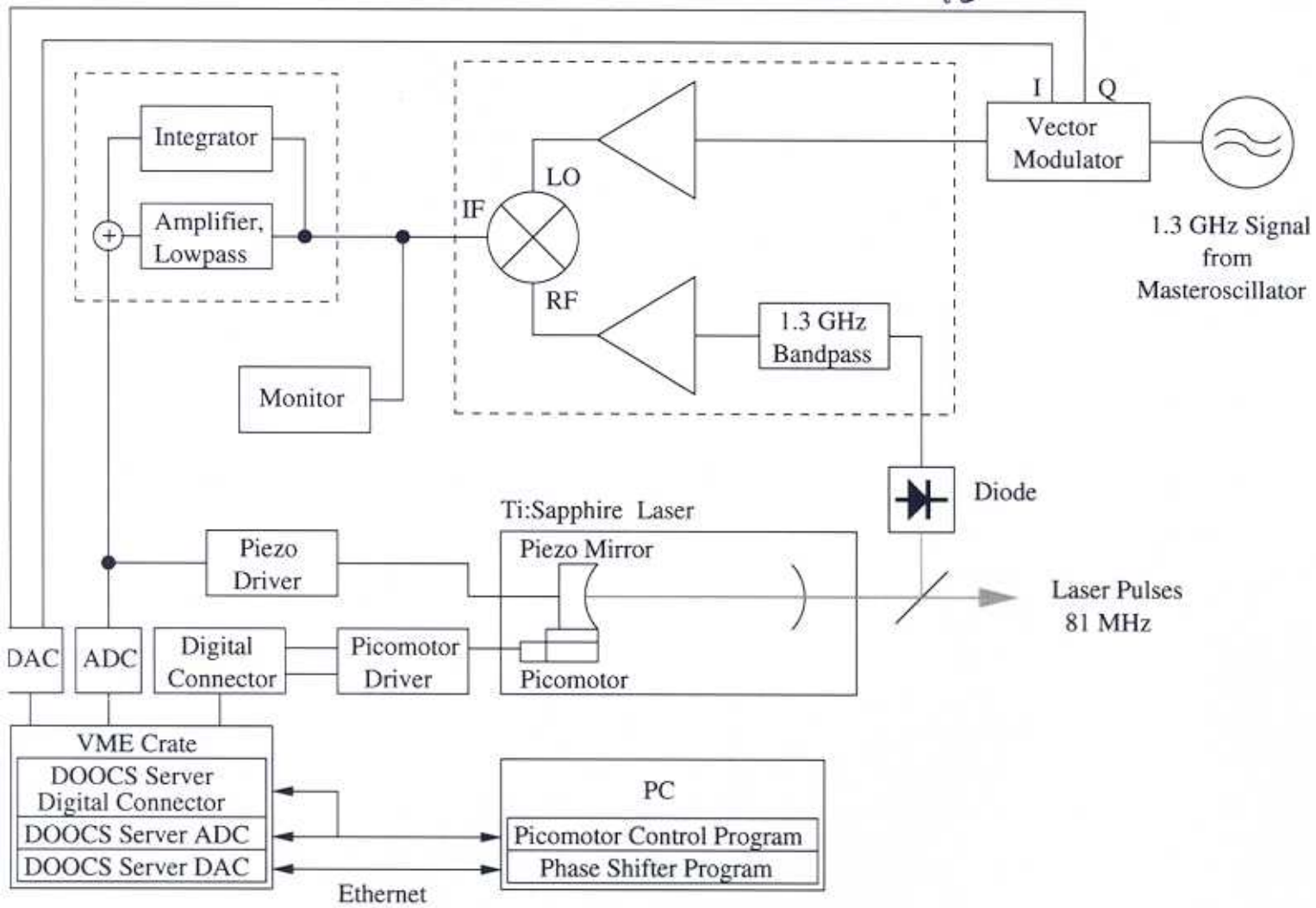


Figure 14: Time variation of vertical laser beam position without and with feedback control.

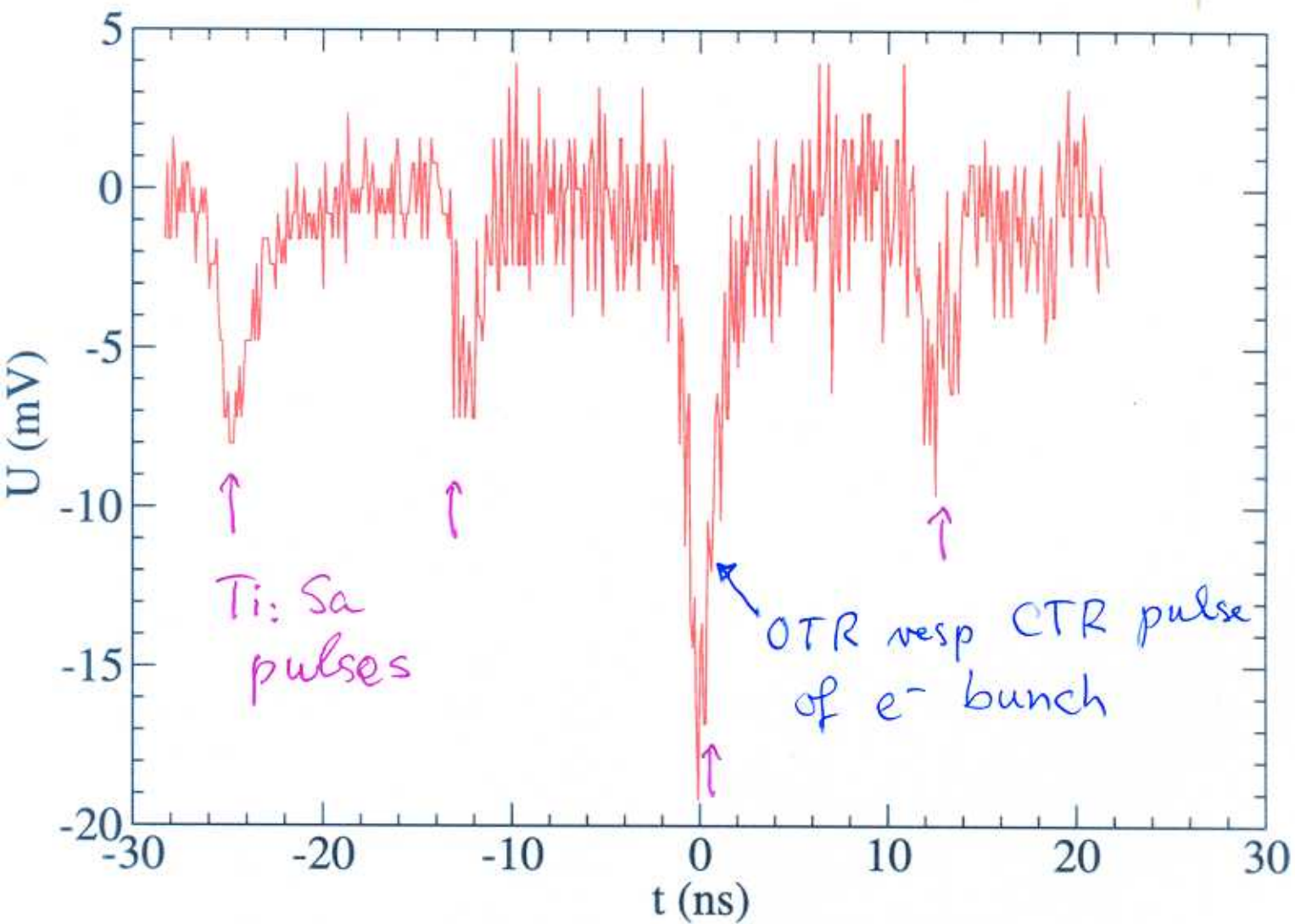
crystal the Ti:Sa laser beam is guided into the box through a 100 mm long aluminium

synchronization Ti: Sa laser to rf
 $81 \text{ MHz} = \frac{1}{16} \cdot 1300 \text{ MHz}$



detector signal on 20 Gs scope

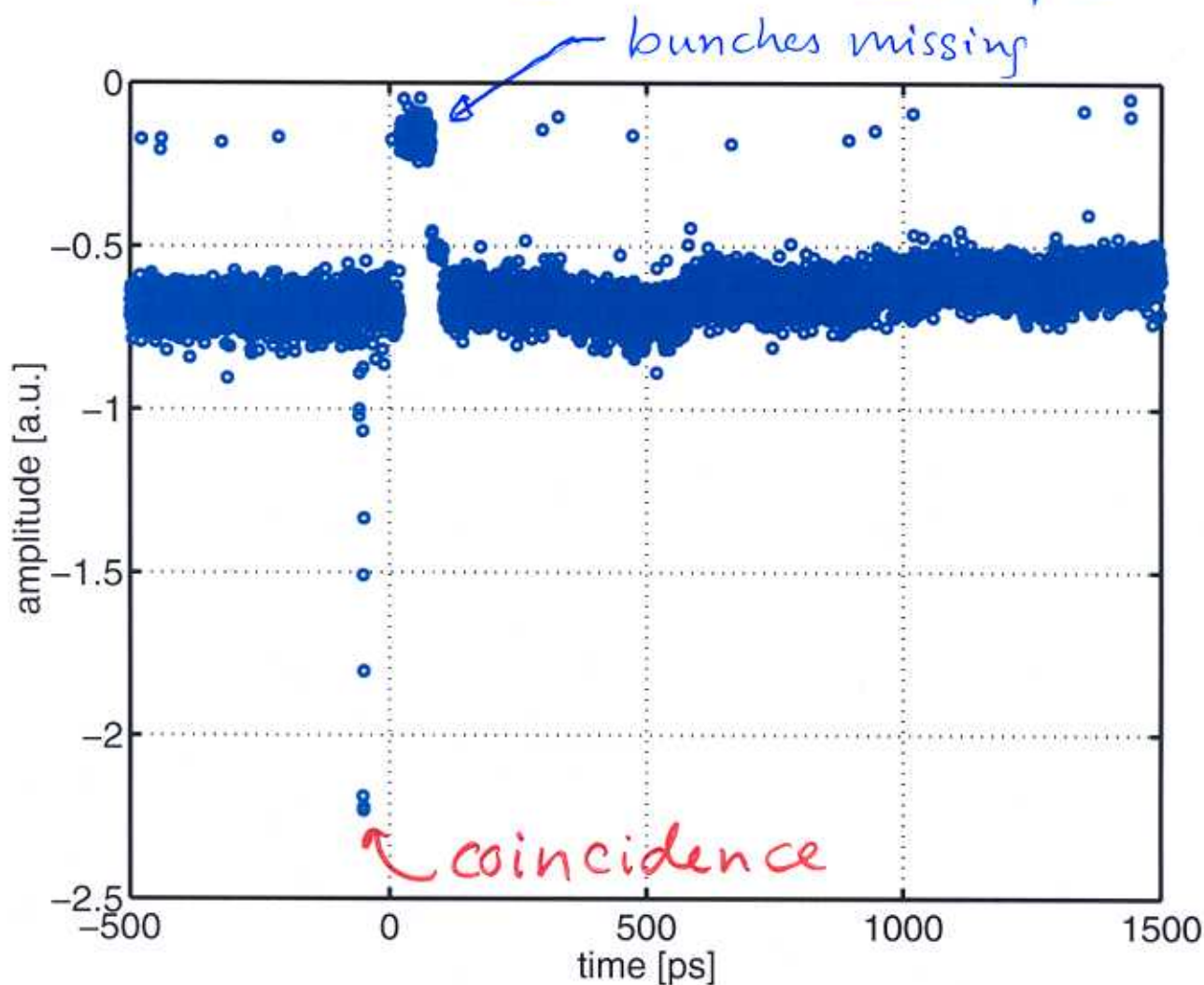
(setup: crossed polarizers, photo multiplier as detector)



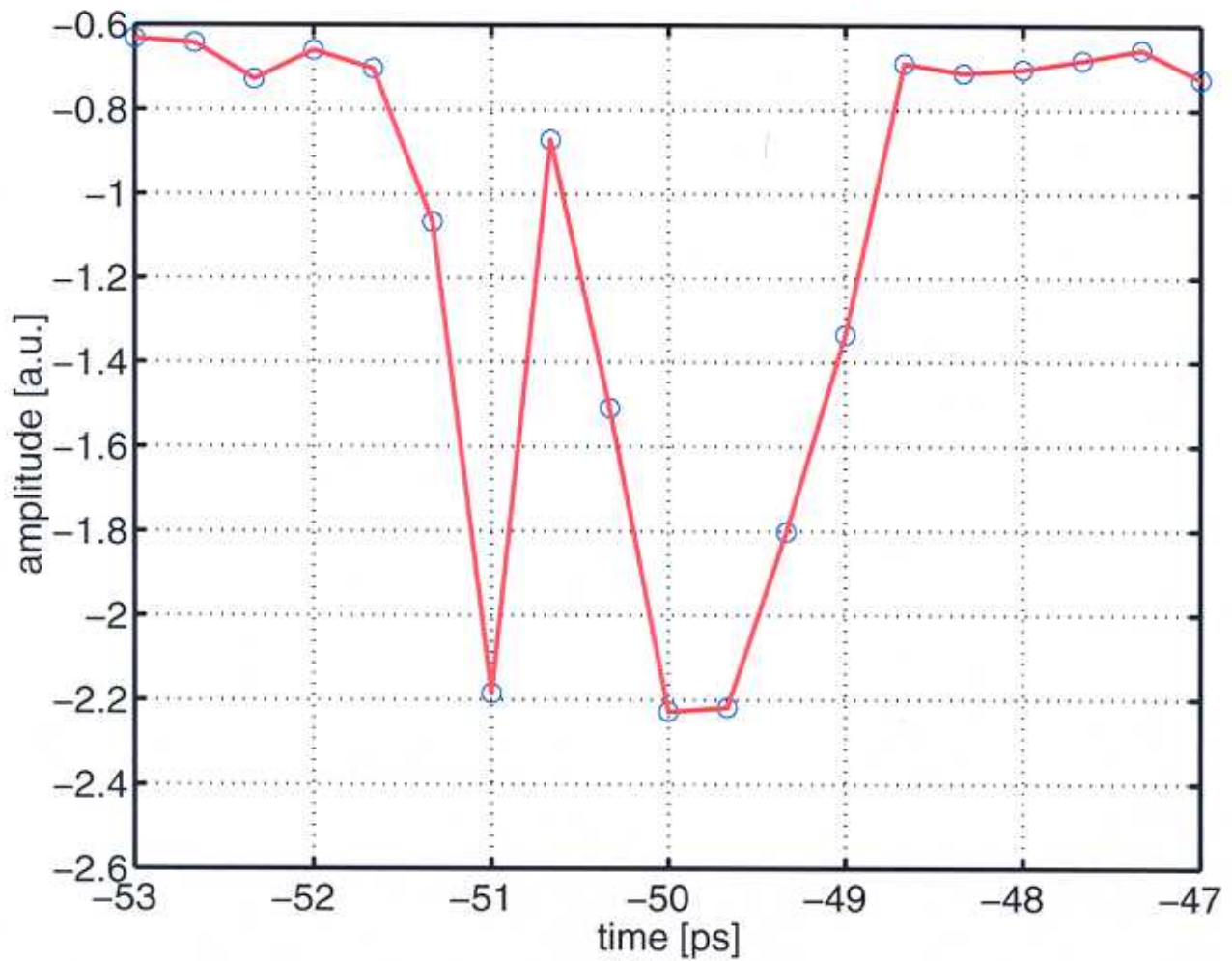
March 2002

Coincidence scan to find overlap
of Ti: Sa pulse (< 20 femtosec) with
CTR - pulse of e - bunch

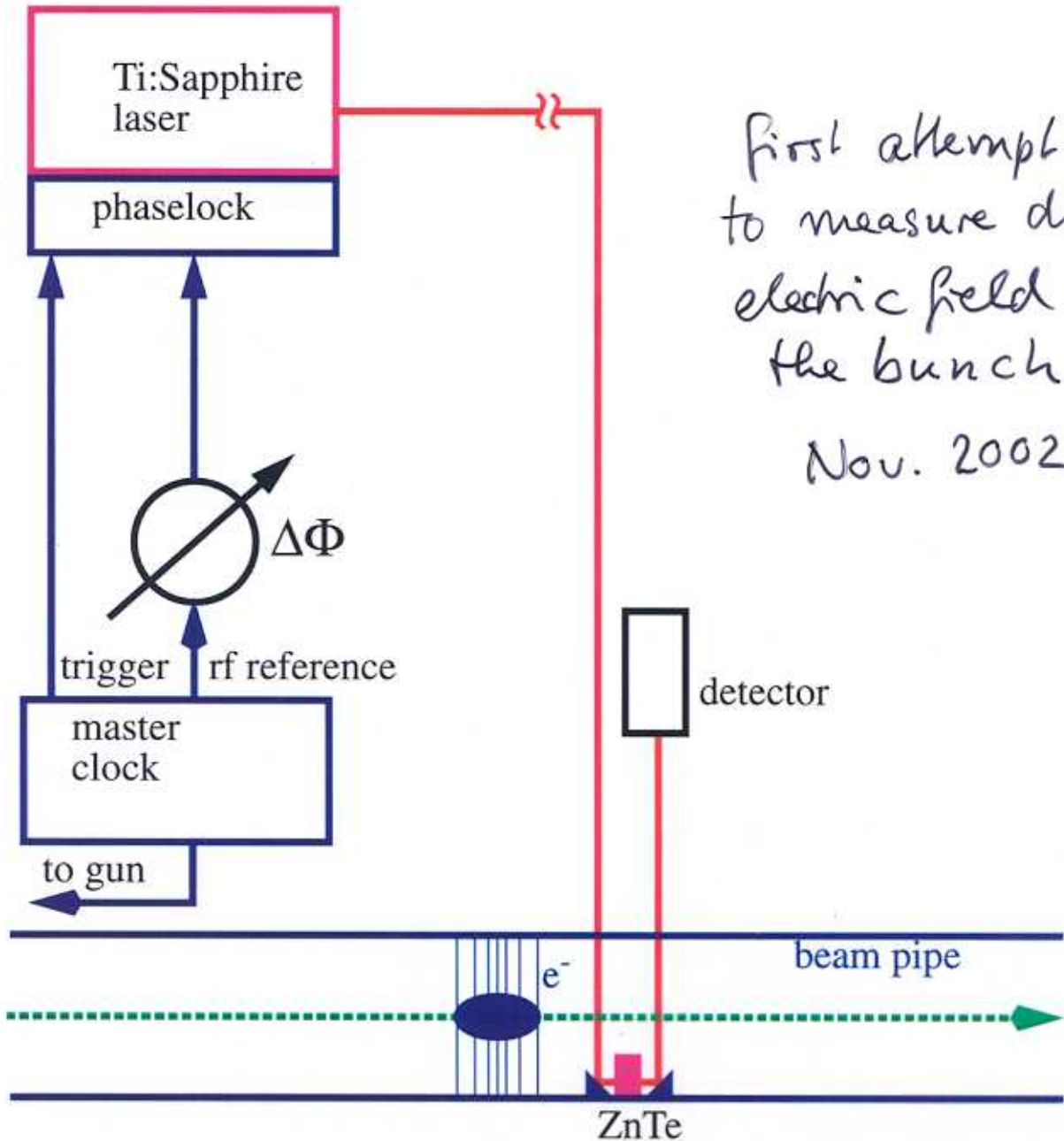
Scan over 2000 ps



Zoom of coincidence
Ti: Sa pulse / CTR pulse



Experimental Setup



- direct measurement of the co-propagating electrical field
- nonintercepting